| NAME OF DEPTT./CENTRE:          | DEPARTMEN        | T OF PHYSICS         |    |
|---------------------------------|------------------|----------------------|----|
| 1. Subject Code: PH-701         | Course Title: La | boratory             |    |
| 2. Contact Hours: L: 0          | T: 0             | P: 6                 |    |
| 3. Examination Duration (Hrs.): | Theory <b>O</b>  | Practical 6          |    |
| 4. Relative Weightage: CWS 0    | PRS <b>50</b>    | 0 0                  | 50 |
| 5. Credits: <b>3</b> 6. Sem     | nester: Autumn   | 7. Subject Area: PCC |    |

8. Pre-requisite: Nil

### 9. Objective: To impart practical knowledge in Solid Sate Electronic Materials

| S. No. |   | Contact |
|--------|---|---------|
|        | Contents  | Hours   |
| 1.     | Study of variation of resistivity with temperature of metal and highly  |         |
|        | resistive materials by Four Probe Technique.  |         |
| 2.     | Mapping and analysis of the resistivity of large samples (thin films,   |         |
| -      | superconductors) by Four probe Technique.   |         |
| 3.     | To study the temperature dependence of Hall coefficient of n- and p- type   |         |
|        | semiconductors.   |         |
| 4.     | (a) To measure the dielectric constant and Curie temperature of given   |         |
|        | terroelectric samples.  |         |
|        | (b) To measure the coercive field ( $E_c$ ), remanent polarization ( $P_r$ ), Curie temperature (T) and granteneous polarization (D) of Parium Titanete |         |
|        | $(\mathbf{P}_{s}, \mathbf{O})$  | 14 x 6  |
| 5      | (Da1103).<br>Thermaluminessense in albeli helides errotels  | 1110    |
| 5.     | Thermoluminescence in alkali handes crystals.   |         |
|        | (a) To produce F centers in the crystal exposing to X-ray /UV source.   |         |
| (      | (b) To determine activation energy of the F-centers by initial rise method.   |         |
| 0.     | verification of Bragg's law and determination of wavelength/energy  |         |
| 7      | Spectrum of X-rays.<br>Study of solar call characteristics and to determine onen aircuit valtage $(V_{ij})^2$   |         |
| 7.     | short airavit current $(1, 2)$ Efficiency $(n)$ fill factor spectral characteristics  |         |
|        | , short encur current $I_{sc}$ , Efficiency ( $\eta$ ), fin factor, spectral characteristics  |         |
|        | and chopper characteristics.  |         |
| 8.     | To measure the magnetoresistance of semiconductor and analyze the plots of  |         |
|        | $\Delta R/R$ and log-log plot of $\Delta R/R$ Vs magnetic field.  |         |
| 9.     | To determine the coercivity, saturation magnetization and retentivity of  |         |
|        | ferromagnetic samples using magnetic hysteresis loop tracer   |         |
| 10.    | To study the temperature dependence of Laser diode characteristics  |         |
| 11.    | To determine transition temperature of given superconducting material and   |         |
|        | study Meissner effect.  |         |
| 12.    | To measure critical current density of given superconductor and study its   |         |
|        | field dependence.   |         |

| 13 | To determine the value of Lande's 'g' factor using ESR spectrometer.      |    |
|----|---|----|
| 14 | To study C-V characteristics of various solid state devices and materials |    |
|    | (like p-n junctions and ferroelectric capacitors).                        |    |
|    | Total   | 84 |

| <b>S.</b> | Name of Authors/Book/Publisher                                | Year of                    |
|-----------|---|----------------------------|
| No.       |   | <b>Publication/Reprint</b> |
| 1.        | Melissinos, A.C. and Napolitano, J., "Experiments in Modern   | 2003                       |
|           | Physics", Academic Press.                                     |                            |
| 2.        | Sze, S.M., "Semiconductor Devices Physics and Technology",    | 2002                       |
|           | John Wiley and Sons.  |                            |
| 3.        | Nakra, B.C. and Chaudhary, K.K., "Instrumentation             | 2002                       |
|           | Measurements and Analysis", Tata McGraw Hill.                 |                            |
| 4.        | Sayer, M. and Mansingh, A., "Measurement, Instrumentation and | 2000                       |
|           | Experiment Design in Physics and Engineering", Prentice Hall. |                            |
| 5.        | Runyan, W.R., "Semiconductor Measurements and                 | 2002                       |
|           | Instrumentation", McGraw Hill                                 |                            |

| NAME OF DEPTT./CENTRE:          | DEPARTMENT OF PHYSICS                            |                   |  |
|---------------------------------|--|-------------------|--|
| 1. Subject Code: <b>PH-703</b>  | Course Title: Semiconductor Materials and Device |                   |  |
|                                 | 1. 1   | 1.0               |  |
| 3. Examination Duration (Hrs.): | Theory 3   | Practical 0       |  |
| 4. Relative Weightage: CWS 25   | PRS 0 25   | 5 50 0            |  |
| 5. Credits: <b>4</b> 6. Seme    | ster: Autumn 7.                                  | Subject Area: PCC |  |

8. Pre-requisite: Nil

9. Objective: To familiarize with semiconducting materials and devices

| S. No. |  | Contact |
|--------|--|---------|
|        | Contents   | Hours   |
| 1.     | Fundamentals of Semiconductors: Energy bands, direct and indirect band gap                           | 10      |
|        | semiconductors, concept of density of states and Fermi-level, carrier concentrations at              |         |
|        | equilibrium, Temperature dependence of carrier concentrations, conductivity and mobility,            |         |
|        | Effects of temperature and doping on mobility, excess carriers, recombination mechanisms,            |         |
|        | carrier lifetime, steady state carrier generation, concept of quasi-Fermi level, drift and diffusion |         |
|        | of carriers, Einstein relation, Continuity equation, Solution of diffusion equation for steady       |         |
|        | state carrier injection, diffusion length, Haynes-Shockley experiment.                               |         |
| 2.     | Junctions: Homo p-n junctions at equilibrium, forward and reverse biased p-n junction,               | 12      |
|        | Carrier injection across p-n junction under forward bias; Derivation of ideal p-n diode current      |         |
|        | equation; reverse saturation current, Real p-n diode V-I characteristics, Reverse breakdown,         |         |
|        | capacitances in p-n diode; Hetero p-n junctions, metal-semiconductor contacts.                       |         |
|        | Bipolar Junction Transistors: Minority carrier distributions and terminal currents, Ebers –          |         |
|        | Moll equations and charge-control analysis. Heterojunction Bipolar Transistors.                      |         |
| 3.     | Field Effect Transistors: Junction Field Effect Transistor (JFET): Structures of n and p-            | 12      |
|        | channel JFET, Pinch-off and saturation, Gate Control, Current Voltage characteristics; Metal-        |         |
|        | Semiconductor FET (MESFET): GaAs MESFET, High Electron Mobility Transistor (HEMT).                   |         |
|        | Metal Oxide Semiconductor FETS (MOSFETs): Structure and working principle of                         |         |
|        | Enhancement type and depletion type MOSFETs. Ideal MOS diode, inversion layer, threshold             |         |
|        | voltage, MOS C-V curve, Effects of work function difference and interface charge on threshold        |         |
|        | voltage, Output and transfer characteristics of enhancement MOSFET, Control of threshold             |         |
|        | voltage, charge-coupled devices (CCD).   |         |
| 4.     | Quantum Effect and Hot Electron Devices: Tunnel diode, Resonant tunneling diode (RTD),               | 8       |
|        | Unipolar Resonant Tunneling Transistor, Hot electron heterojunction bipolar transistors              |         |
| L      | (HEHBT), Transferred Electron Devices, Gunn diode and its applications.                              |         |
|        | Total  | 42      |

| 11.    | Suggested Books:  |                                |
|--------|---|--------------------------------|
| S. No. | Name of Authors/Book/Publisher  | Year of<br>Publication/Reprint |
| 1.     | Streetman, B.G., Banerjee, S. K. "Solid State Electronic Devices", Sixth Edition, PHI Learning Private Limited. | 2013                           |
| 2.     | Sze, S.M., "Semiconductor Devices: Physics and Technology", Second Edition, John Wiley and Sons.                | 2002                           |
| 3.     | Tyagi, M.S., "Semiconductor Materials and Devices", John Wiley and Sons.  | 2008                           |
| 4.     | Millman J, Halkias C. C., Satyabrata J, "Electronic Devices & Circuits", Tata McGraw Hill                       | 2007                           |

| NAME OF DEPTT./CENTRE:          | DEPARTMENT OF PHYSICS                       |                      |   |
|---------------------------------|---|----------------------|---|
| 1. Subject Code: PH-705         | Course Title: Characterization of Materials |                      |   |
| 2. Contact Hours: L: 3          | T: 1  | P: 0                 |   |
| 3. Examination Duration (Hrs.): | Theory <b>3</b>                             | Practical 0          |   |
| 4. Relative Weightage: CWS 25   | PRS 0                                       | 25 50                | 0 |
| 5. Credits: <b>4</b> 6. Sem     | nester: Autumn                              | 7. Subject Area: PCC | 1 |

### 8. Pre-requisite: Nil

- 9. Objective: To introduce various methods of characterization of materials for their structural, electrical, magnetic and optical properties.
- 10. Details of Course:

| S.  |  | Contact |
|-----|--|---------|
| No. | Contents   | Hours   |
| 1.  | Crystal Structure Determination: Brief description of crystal lattices; X-   | 12      |
|     | ray diffractometer; Determination of crystal structure using X-ray   |         |
|     | diffraction  |         |
| 2.  | <b>Electron Microscopes:</b> Brief description of different microscopes like TEM, SEM, AFM; Modes of operation of microscopes, sample preparation, Interpretation of electron diffraction and determination of crystal structure; morphology of the crystals.                    | 11      |
| 3.  | <b>Thermal Analysis:</b> Thermogravimetric analysis, Differential thermal analysis and Differential scanning calorimetry and methodology; Determination of phase transitions using these methods.  | 5       |
| 4.  | <b>Electrical and Magnetic Property:</b> Measurement of electrical conductivity in different materials- insulators, metals and semiconductors using four probe and Hall effect method. Vibrating Sample Magnetometer (VSM), Superconducting Quantum interference Devices (SQUID) | 8       |
| 5.  | <b>Optical Characterization:</b> Optical characterization of materials using photoluminescence and UV-visible spectroscopy.  | 3       |
| 6.  | <b>Chemical Analysis:</b> Brief description to X-ray fluorescence, atomic absorption and electronic spin resonance spectroscopy.   | 3       |
|     | Total  | 42      |

| S.  | Name of Authors/Book/Publisher                                  | Year of             |
|-----|---|---------------------|
| No. |   | Publication/Reprint |
| 1.  | Culity, B. D., "Elements of X-ray Diffraction", Addison-Wesley. | 2001                |
| 2.  | Grundy, P. J. and Jones, G. A., "Electron Microscopy in the     | 1976                |
|     | Study of Materials", Edward Arnold.                             |                     |
| 3.  | Egerton, R. F., "Physical Principles of Electron Microscopy",   | 2008                |
|     | Springer.   |                     |
| 4.  | Willard, H. H., Merritt, L. L. and Dean, J. A., "Instrumental   | 1991                |
|     | Methods of Analysis", CBS publications.                         |                     |
| 5.  | Fultz, B. and Howe, J. M., "Transmission Electron Microscopy    | 2007                |
|     | and Diffractometry of Materials", Springer.                     |                     |

| NAME OF DEPTT./CENTRE:          | DEPARTMENT OF PHYSICS |                             |                |
|---------------------------------|-----------------------|-----------------------------|----------------|
| 1. Subject Code: PH-707         | Course Title:         | Computational Techniques an | nd Programming |
| 2. Contact Hours: L: 2          | T: 0                  | P: 2                        |                |
| 3. Examination Duration (Hrs.): | Theory                | 2 Practical 2               |                |
| 4. Relative Weightage: CWS 10   | ) PRS 15              | 15 30                       | 30             |
| 5. Credits: <b>3</b> 6. Sen     | nester: Autumn        | 7. Subject Area: PCC        |                |

8. Pre-requisite: Nil

9. **Objective of Course:** To provide the knowledge of computation with suitable mathematical software and its applications to solve the problems of condensed matter physics.

| S.  |   | <b>Contact Hours</b> |
|-----|---|----------------------|
| No. | Contents  |                      |
| 1.  | <b>Introduction to mathematical software/language:</b> Concept of programming in FORTRAN/Matlab/Mathematica, input/output, interactive input, loading and saving data, loops, branches and control flow, matrix and array operations, eigenvalues and eigenvectors.   | 6                    |
| 2.  | <b>Sub programs:</b> Array of dimensional variables, subroutines, sub-<br>programming, functions sub-programming, Advantages of modular<br>programming, built-in functions, scripts, functions, sharing of variables<br>between modules.  | 5                    |
| 3.  | <b>Graphics:</b> 2D plots, style options, axis control, overlay plots, subplot, histogram, 3D plots, mesh and surface plots, contour plots.   | 4                    |
| 4.  | <b>Numerical computation:</b> Computer programs for: solving linear system of simultaneous equations, nonlinear algebraic equation, roots of polynomials, curve fitting, polynomial curve fitting, least square curve fitting, interpolation, data analysis and statistics. Numerical integration, Quadrature, Monte-Carlo simulation, ordinary differential equation, first order and second order ODEs, partial differential equation methods (the finite difference method & the finite element method). | 13                   |
|     | Total   | 28                   |

| S.  | Name of Authors/Book/Publisher   | Year of                    |
|-----|--|----------------------------|
| No. |  | <b>Publication/Reprint</b> |
| 1.  | Pratap, R., "Getting started with MATLAB 7", Oxford University Press.            | 2006                       |
| 2.  | Gilat, A., "Matlab: An Introduction with Applications", Wiley.                   | 2008                       |
| 3.  | Tao, P., "Computational Physics", Cambridge University Press.                    | 2005                       |
| 4.  | David, P., "Computational Physics", John Wiley & Sons                            | 1973                       |
| 5.  | Wolfram, S., "The Mathematica Book," 5 <sup>th</sup> Ed., Wolfram Media          | 2003                       |
| 6.  | Gerald, C. F. and Wheatley, P. O., "Applied Numerical Analysis", 7 <sup>th</sup> | 2003                       |
|     | Ed, Addison Wesley   |                            |

| S. No. | List of Experiments                                      |
|--------|--|
| 1.     | Eigen-value problem: 1-D square potential well           |
| 2.     | Stochastic methods for multidimensional integrals        |
| 3.     | Study of systems with chaotic dynamics                   |
| 4.     | Solving Kronig-Penny Model                               |
| 5.     | Study of doping profile in semiconductors                |
| 6.     | Variation of dielectric constant for composite materials |
| 7.     | Calculation of modes of an optical waveguide             |
| 8.     | Monte-Carlo simulations (Ising Model of magnetism)       |
| 9.     | Molecular Dynamics Simulations                           |

| NAME OF DEPTT./CENTRE:          | DEPARTM        | IENT OF PHY     | SICS          |   |
|---------------------------------|----------------|-----------------|---------------|---|
| 1. Subject Code: PH-702         | Course Title:  | Nanomaterials a | and Technolog | У |
| 2. Contact Hours: L: 3          | T: 1           | Р:              | 0             |   |
| 3. Examination Duration (Hrs.): | Theory         | 3 Practi        | cal 0         |   |
| 4. Relative Weightage: CWS 25   | prs 0          | 25              | 50            | 0 |
| 5. Credits: <b>4</b> 6. Sem     | nester: Spring | 7. Subject      | t Area: PEC   |   |

8. Pre-requisite: NIL

### 9. **Objective of Course:** To impart knowledge of nanomaterials and technology

| S.<br>No. | Contents  | Contact<br>Hours |
|-----------|---|------------------|
| 1         |   | 10               |
| 1.        | Physics of Low-dimensional Materials: An overview of quantum                  | 10               |
|           | mechanical concepts related to low dimensional systems, classifications of    |                  |
|           | quantum confined systems, electrons and holes in quantum wells, electronic    |                  |
|           | wave functions, energy sub-bands and density of electronic states in quantum  |                  |
|           | wells, quantum wires and quantum dots   |                  |
| 2.        | Synthesis and Characterization of Nanomaterials: various top down and         | 12               |
|           | bottom up approaches for synthesis of nanomaterials, overview of thin film    |                  |
|           | technology for nanotechnology applications, physical vapour deposition and    |                  |
|           | chemical vapour deposition techniques, synthesis of zero, one dimensional     |                  |
|           | and two dimensional nano structures, characterization of nano materials using |                  |
|           | XRD AFM STM FESEM and SOUID   |                  |
| 3         | <b>Properties of Nano Materials:</b> Phenomena and properties at panoscale    | 08               |
| 5.        | mechanical/frictional optical electrical and magnetic properties              | 00               |
| 4         | Nanofabrication and Device Applications: Miniaturization of electrical and    | 12               |
| ••        | electronic devices Moore's law papofabrication using lithography              | 12               |
|           | techniques electron beam lithography X ray lithography soft                   |                  |
|           | nanolithography and din pen nanolithography, A-ray hunography, soft           |                  |
|           | nanonulography and up per nanonulography, electronic devices based on         |                  |
|           | nanostructures, single electron transistor, future of sincon computer         |                  |
|           | technology, near dissipation and kapid Single Flux Quantum (RSFQ)             |                  |
|           | technology, quantum dot lasers, superconducting Josephson junctions, energy   |                  |
| L         | storage and fuel cells  |                  |
|           | Total   | 42               |

| 11. | Suggested Books:  |                            |
|-----|---|----------------------------|
| S.  | Name of Authors/Books/Publishers                              | Year of                    |
| No. |   | <b>Publication/Reprint</b> |
| 1.  | Edelstein A. A. and Cammarata R .C., "Nanomaterials-          | 1998                       |
|     | Synthesis, Properties and Applications", Institute of Physics |                            |
|     | Publishing, London  |                            |
| 2.  | Nalwa H.S., "Handbook of Nanostructured Materials and         | 2000                       |
|     | Nanotechnology", Vols. 1-5, Academic Press                    |                            |
| 3.  | Benedek G., Milani P. and Ralchenko V. G., "Nanostructured    | 2001                       |
|     | Carbon for advanced Applications", Kluwer Academic            |                            |
|     | Publishers  |                            |
| 4.  | Dresselhaus M.S., Dresselhaus G. and Eklund P., "Science of   | 1996                       |
|     | Fullerenes and Nanotubes", Academic Press                     |                            |
| 5.  | Wilson M, Kannangawa K, Smith G, Simmons M and Raguse         | 2002                       |
|     | B., "Nanotechnology: Basic Science and Emerging               |                            |
|     | Technologies", Chapman and Hall                               |                            |

| NAME OF DEPTT./CENTRE:          | DEPARTMENT          | OF PHYSICS           |
|---------------------------------|---------------------|----------------------|
| 1. Subject Code: PH-704         | Course Title: Quant | tum Heterostructures |
| 2. Contact Hours: L: 3          | T: 1                | P: 0                 |
| 3. Examination Duration (Hrs.): | Theory <b>3</b>     | Practical 0          |
| 4. Relative Weightage: CWS 25   | PRS 0               | 25 50 0              |
| 5. Credits: <b>4</b> 6. Sem     | ester: Spring       | 7. Subject Area: PEC |

- 8. Pre-requisite: NIL
- 9. **Objective of Course:** To impart knowledge of size-quantization in nanosystems and semiconductor heterostructure quantum devices

| S.  | Contort  | Contact |
|-----|--|---------|
| N0. | Contents   | Hours   |
| 1.  | Electrons in Quantum Confined Systems: Density of states function in           | 10      |
|     | quantum wells, quantum wires, quantum dots and super lattices, coupling of     |         |
|     | quantum wells, Type-I and Type-II heterostructures                             |         |
| 2.  | Electron Transport in nanostructures: Parallel and perpendicular transport     | 08      |
|     | in quantum structures, linear electron transport, hot electron transport, real |         |
|     | space transfer of hot electrons  |         |
| 3.  | Quantum Tunneling: Single and double barrier cases, resonant tunneling,        | 08      |
|     | resonant tunnel diode characteristics and mechanisms, resonant tunnel          |         |
|     | transistors  |         |
| 4.  | Heterostructure Devices: Super lattices and ballistic-injection devices, Block | 08      |
|     | oscillations, Wannier-Stark energy ladder, single electron transfer and        |         |
|     | Coulomb blockade, velocity modulation interference transistors (vmt)           |         |
| 5.  | Quantum Optical Devices: Quantum well lasers, multiple quantum well            | 08      |
|     | lasers, cascade lasers, optical modulators and quantum well photodetectors     |         |
|     | Total  | 42      |

| 11.       | Suggested Books:  |                            |
|-----------|---|----------------------------|
| <b>S.</b> | Name of Authors/Books/Publishers                                | Year of                    |
| No.       |   | <b>Publication/Reprint</b> |
| 1.        | Mitin V.V., Kochelap V. A. and Stroscio M. A., "Quantum         | 1999                       |
|           | Heterostructures: Microelectronics and Optoelectronic Devices", |                            |
|           | Cambridge University Press                                      |                            |
| 2.        | Ferry D.K. and Goodnick S.M., "Transport in Nanostructures",    | 1997                       |
|           | Cambridge University Press                                      |                            |
| 3.        | Shik A., "Quantum Wells: Physics and Electronics of Two-        | 1998                       |
|           | Dimensional Systems", World Scientific                          |                            |

| NAME OF DEPTT./CENTRE:          | DEPARTMENT         | OF PHYSICS          |            |
|---------------------------------|--------------------|---------------------|------------|
| 1. Subject Code: PH-706         | Course Title: Func | tional Materials aı | nd Devices |
| 2. Contact Hours: L: 3          | T: 1               | P: 0                |            |
| 3. Examination Duration (Hrs.): | Theory <b>3</b>    | Practical           | 0          |
| 4. Relative Weightage: CWS 25   | PRS 0              | 25 50               | 0          |
| 5. Credits: <b>4</b> 6. Sem     | ester: Spring      | 7. Subject Area: I  | PEC        |

8. Pre-requisite: NIL

### 9. **Objective of Course:** To impart knowledge of functional materials and devices

| S.<br>No. | Contents  | Contact<br>Hours |
|-----------|---|------------------|
| 1.        | Scope of functional ceramics, classification according to their different functions, electrical and electronic conduction in ceramics, defect chemistry, ionic conductivity, ceramic electrolytes and fast ion conductors, ceramic insulators; Ceramic Capacitors, piezoelectric, ferroelectric and electro optic ceramics - material systems, processing and fabrication | 10               |
| 2.        | Electroceramic thin film technology, materials and deposition methods, application of thin films in microelectronics and microsystems; Multilayer ceramic technology- processing of multi layer ceramics, sintering of multilayer structure, low temperature co-fired glass ceramics  | 10               |
| 3.        | Smart functional role of the materials in devices which depends on their electrical, optical and thermal properties, smart transducers, optical fibers, optical coatings, liquid crystal displays, optical storage devices, ruby laser, solar cell, ceramic insulators, Peltier cooler  | 8                |
| 4.        | Ceramic sensors and resistors- classification, operating principles of different<br>sensors, preparation and applications; Positive and negative temperature<br>coefficient ceramic thermistors, gas, humidity and pressure sensors, ZnO-<br>varistors technology, varistor microstructure and fabrication, Varistor<br>application                                       | 7                |
| 5.        | Ceramic membranes- classifications, material requirements, preparation and applications, special glass and glass ceramics for defence applications  | 7                |
|           | Total   | 42               |

| S.  | Name of Authors/Books/Publishers  | Year of                    |
|-----|---|----------------------------|
| No. |   | <b>Publication/Reprint</b> |
| 1.  | Buchanan R. C., "Ceramic Materials for Electronics", 3 <sup>rd</sup> Ed, Marcel | 2004                       |
|     | Dekker, NY  |                            |
| 2.  | Moulson A. J. and Herbert J. M., "Electroceramics: Materials,                   | 2003                       |
|     | Properties and Applications", Wiley; 2 <sup>nd</sup> Ed.                        |                            |
| 3.  | Bachs H. and Krause D., "Low Thermal Expansion Glass Ceramics",                 | 2005                       |
|     | Springer  |                            |
| 4.  | Setter N., "Electroceramic based MEMS: Fabrication Technology                   | 2005                       |
|     | and Applications", Springer   |                            |
| 5.  | Nenov T. G., Yordanov S. P. and Nenov N., "Ceramic Sensors:                     | 1996                       |
|     | Technology and Applications", CRC Press   |                            |
| 6.  | Wang Z. L., Wang W. Z. L. and Kang Z. C., "Functional and Smart                 | 1998                       |
|     | Material", Springer   |                            |
| 7.  | Jaffe B., Cook W. R., Jaffe H. and Jaffe H. L. C., "Piezoelectric               | 1990                       |
|     | Ceramics", R.A.N Publishers   |                            |

| NAME OF DEPTT./CENTRE:          | DEPARTMENT            | OF PHYSICS           |
|---------------------------------|-----------------------|----------------------|
| 1. Subject Code: PH-708         | Course Title: Solar P | hotovoltaic          |
| 2. Contact Hours: L: 3          | T: 1                  | P: 0                 |
| 3. Examination Duration (Hrs.): | Theory <b>3</b>       | Practical 0          |
| 4. Relative Weightage: CWS 25   | ; PRS 0               | 25 50 0              |
| 5. Credits: <b>4</b> 6. Sem     | nester: Spring        | 7. Subject Area: PEC |

8. Pre-requisite: Nil

9. Objective: To learn the fundamentals, design and application of solar photovoltaic systems for power generation on small and large scale electrification.

| S. No. | Contents   | Contact<br>Hours |
|--------|--|------------------|
| 1.     | <b>Review of Semiconductor Physics:</b> Electrons and holes in semiconductors, doping, electrical transport, Photo carrier generation and recombination; p-n and p-i-n Junctions; metal semiconductor contacts, band bending, Ohmic and rectifying contacts, Surface and interface states, homo and hetero-junctions; Depletion region, depletion capacitance, Carrier and current densities, Current voltage characteristics in dark and light                    | 9                |
| 2.     | <b>Device Physics of Solar Cells:</b> Photovoltaic effect - Principle of direct solar energy conversion into electricity in a solar cell. Semiconductor properties, energy levels, basic equations. Solar cell, p-n junction, structure. Solar radiation, conversion efficiency, p-n junction model, Effect of Parasitic resistance, irradiation and temperature on I-V characteristics. Numerical solar cell modeling   | 9                |
| 3.     | <b>Principle of cell design:</b> Cell type, Optical design, surface and bulk recombination losess, design and fabrication of metal contacts, Crystalline Silicon and III-V Solar cells: Single, tandem and multi-junction solar cells, Thin Film Solar cells: Amorphous silicon, cadmium telluride and copper indium gallium diselenide based solar cells  | 9                |
| 4.     | <b>Photovoltaic System Engineering:</b> Thermo-photovoltaic generation of electricity, Concentration and storage of electrical energy, photovoltaic modules, system and application  | 5                |
| 5.     | <b>NANOMATERIALS FOR PHOTOVOLTAICS</b> Photochemical solar cells, PV panels with nanostructures. Phase compositions on nanoscale microstructures – role of nanostructures and materials – nanomaterials in solar photovoltaic technology- band gap engineering and optical engineering - tandem structures - quantum well and quantum dot solar cells - photo-thermal cells – organic solar cells. Performance and reliability of nanomaterials based solar cells. | 10               |
|        | Total  | 42               |

| S. No. | Name of Authors/Book/Publisher   | Year of<br>Publication/Reprint |
|--------|--|--------------------------------|
| 1.     | Jasprit Singh, "Semiconductor Devices, Basic Principles", Wiley                  | 2001                           |
| 2.     | Jenny Nelson, "The Physics of Solar Cells", Imperial College Press               | 2003                           |
| 3.     | Stephen J. Fonash, "Solar Cell Device Physics", 2nd edition, Academic Press      | 2010                           |
| 4.     | A. Luque and S. Hegedus, "Handbook of Photovoltaic Science & Engineering", Wiley | 2003                           |
| 5.     | Tsakalakos.L., "Nanotechnology for Photovoltaic's", CRC                          | 2010                           |

| NAME OF DEPTT./CENTRE:          | DEPARTMENT OF PHYSICS |                      |       |
|---------------------------------|-----------------------|----------------------|-------|
| 1. Subject Code: PH-710         | Course Title: Advanc  | ed Ceramics & Compo  | sites |
| 2. Contact Hours: L: 3          | T: 1                  | P: 0                 |       |
| 3. Examination Duration (Hrs.): | Theory <b>3</b>       | Practical 0          |       |
| 4. Relative Weightage: CWS 25   | PRS 0                 | 25 50                | 0     |
| 5. Credits: <b>4</b> 6. Sem     | nester: Autumn        | 7. Subject Area: PEC |       |

8. Pre-requisite: Nil

9. Objective: The course is aimed to impart basic understanding about ceramics, fibres and composites with their properties, manufacturing routes and applications.

| 10. | Details of Course: |
|-----|--------------------|
|-----|--------------------|

| S. No. | Contents  | Contact<br>Hours |
|--------|---|------------------|
| 1.     | INTRODUCTION: oxide and non-oxide ceramics, their chemical formulae, crystal and defect structures, non-stoichiometry and typical properties.   | 4                |
| 2.     | POWDER PREPARATION: Physical methods (different techniques of grinding), chemical routes - co-precipitation, sol-gel, hydrothermal, combustion synthesis, high temperature reaction (solid state reaction).   | 5                |
| 3.     | BASIC PRINCIPLES AND TECHNIQUES OF CONSOLIDATION AND SHAPING OF<br>CERAMICS: powder pressing- uniaxial, biaxial and cold isostatic and hot isostatic, injection<br>moulding, slip casting, tape-casting, calendaring, multilayering.<br>Sintering: different mechanisms and development of microstructure (including microwave<br>sintering) Preparation of single crystal, thick and thin film ceramics  | 5                |
| 4.     | EXOTIC CERAMICS: functionally graded, smart/ Intelligent, bio-mimetic and nano-<br>ceramics - basic principles, preparation and applications  | 6                |
| 5.     | COMPOSITES: Introduction to composite materials – definition, characteristics, classification; Matrix Materials – polymers, metals and ceramics; Fabrication of thermosetting resin matrix composites, thermoplastic resin matrix composites, metal matrix composites, carbon – carbon composites, their preparation and properties (including nano-composites); Engineering applications: at room and high temperatures (including armour application) | 8                |
| 6      | Transparent ceramics, coatings and films: preparation and applications  | 3                |
| 7.     | SPACE CERAMICS: Materials aspects of missile and satellite reentry, auxiliary space<br>powder devices- rocket nozzle technology- the space environment and its effects.<br>Quantitative analysis of texture, nature of grain boundaries, development of<br>microstructure, grain growth, microstructure in glass ceramics, effect of particle size,<br>pressure and sintering, dependence of mechanical and thermal properties on<br>microstructure.    | 6                |
| 8.     | CERAMIC FIBRES Introduction – difference between material in bulk form and fibre form, types of fibres, fibre flexibility, fibre manufacturing technology, glass fibres: manufacture & applications, carbon and graphite fibres, grades of carbon fibres.   | 5                |
|        | Total   | 42               |

| 11. Suggested Boo | oks: |
|-------------------|------|
|-------------------|------|

| S. No. | Name of Authors/Book/Publisher                                      | Year of Publication/Reprint |
|--------|---|-----------------------------|
| 1.     | Michel W. Barsoum, M. W., "Fundamental of Ceramics", McGraw Hill    | 1997                        |
|        | International edition   |                             |
| 2.     | Richerson, D.W., "Modern Ceramic Engineering", Mercel Dekker NY     | 1992                        |
| 3.     | Rahman, M. N., "Ceramic Processing and Sintering", Mercel Dekker    | 2003                        |
| 4.     | Somiya, S., "Handbook of Advanced Ceramics", Academic Press         | 2003                        |
| 5.     | Somiya, S., "Handbook of Advanced Ceramics, Parts 1 and 2, Academic | 2006                        |
|        | Press   |                             |



- 9. Objective: To impart knowledge of photons and semiconductors physics of optoelectronic devices
- 10. Details of Course:

| S. No. |  | <b>Contact Hours</b> |
|--------|--|----------------------|
|        | Contents   |                      |
| 1.     | Interaction of photons with atoms, spontaneous emission, stimulated<br>emission and absorption, line broadening, the laser amplifier, theory of<br>laser oscillation, characteristics of laser output, characteristics of common<br>lasers   | 6                    |
| 2.     | Semiconductors- energy bands and charge carriers, binary, ternary and<br>quaternary semiconductors, generation, recombination and injection<br>processes, junctions, hetrojunctions, quantum wells, superlattices,<br>interaction of photons with electrons and holes, band-to-band absorption<br>and emission, rates of absorption and emission, refractive index | 8                    |
| 3.     | Light emitting diodes, injection electroluminescence, LED characteristics,<br>semiconductor laser amplifier, gain, pumping, hetrostructures,<br>semicunductor injection lasers, amplification, feedback and oscillation,<br>power, spectral distribution, mode selection, characteristics of typical<br>semiconductor lasers, quantum well lasers                  | 8                    |
| 4.     | Properties of semiconductor photodetectors, quantum efficiency, responsivity, response time, Photoconductors- photodiodes, p-n and p-i-n photodiode, hetrostructure photodiodes, array detectors, avalanche photodiodes, noise in photodetectors   | 7                    |
| 5.     | Principles of electron optics, Pockels and Kerr effects, electro-optic modulators and switches, scanners, directional couplers, spatial light modulators, electro-optics of anisotropic media and liquid crystals,   | 6                    |

|    | photorefractive materials  |    |
|----|--|----|
| 6. | Integrated optic planar waveguides, mechanism of light guidance,   | 7  |
|    | integrated optic components, directional coupler, optical fiber, step-index, graded-index, single-mode fibers, optical fiber components, fused fiber coupler, fiber Bragg gratings, long-period fiber gratings, sources for optical transmitters, detectors for optical receivers, fiber-optic systems |    |
|    | Total  | 42 |

| <b>S.</b> | Authors/Name of Books/Publisher                                     | Year of     |
|-----------|---|-------------|
| No.       |   | Publication |
| 1.        | Saleh B. E. A. and Teich M. C., "Fundamentals of Photonics", John   | 1991        |
|           | Wiley and Sons, Inc.  |             |
| 2.        | Ghatak A. and Thyagarajan K., "Optical Electronics", Cambridge      | 2003        |
|           | University Press  |             |
| 3.        | Yariv A, "Quantum Electronics", 3 Ed., John Wiley and Sons          | 1988        |
| 4.        | Streetman B.G. and Banerjee S., "Solid State Electronic Devices", 6 | 2006        |
|           | Ed. Prentice Hall   |             |

| NAME OF DEPTT./CENTRE:          | DEPARTM        | ENT OF PHYSICS      |                        |
|---------------------------------|----------------|---------------------|------------------------|
| 1. Subject Code: PH-714         | Course Title:  | Semiconductor Micro | -Electronic Technology |
| 2. Contact Hours: L: 3          | T: 1           | P: 0                |                        |
| 3. Examination Duration (Hrs.): | Theory         | 3 Practical         | 0                      |
| 4. Relative Weightage: CWS 25   | PRS 0          | 25 50               | 0                      |
| 5. Credits: <b>4</b> 6. Sen     | nester: Spring | 7. Subject Area:    | PEC                    |

9. **Objective:** To impart knowledge of physics of semiconductor devices and their fabrication

8. Pre-requisite:

technologies.

Nil

10. Details of Course: S. **Contact Hours** Contents No. Crystal Growth and Epitaxy: Single crystal growth techniques of Silicon and 1. 10 GaAs, epitaxial growth techniques, structures and defects in epitaxial layers, thermal oxidation of silicon including the Deal-Grove model 2. Film Formation: Vacuum science, vacuum technology and basic physics of a 7 plasma, thermal oxidation of Si, deposition of SiO<sub>2</sub> film by CVD technique 3. Lithography: Optical and nonoptical lithography, electron beam lithography, 8 X-ray lithography, etching techniques- wet and dry etch processes including reactive ion and high density plasma etching 4. Impurity Doping: Impurity diffusion in semiconductors, diffusion 9 mechanisms, and rapid thermal processes, diffusion process, diffusion equation, diffusion profiles, evaluation of diffused layers, ion implantationrange of implanted ions, ion distribution, ion stopping, ion channeling, implant damage and annealing 5. Integrated devices: Fabrication of active and passive components in an 8 integrated circuit, bipolar, MOSFET and MESFET technologies Total 42

| 11.       | Suggested Books:  |                            |
|-----------|---|----------------------------|
| <b>S.</b> | Name of Authors/Books/Publishers  | Year of                    |
| No.       |   | <b>Publication/Reprint</b> |
| 1.        | Sze S.M., "Semiconductor Devices: Physics and Technology", John         | 2002                       |
|           | Wiley and Sons  |                            |
| 2.        | Streetman B.G. and Banerjee S., "Solid State Electronic Devices", 6 Ed. | 2006                       |
|           | Prentice Hall   |                            |
| 3.        | Gandhi S.K., "VLSI Fabrication Principles", John Wiley and Sons         | 1994                       |
| 4.        | Nagchoudhuri D., "Microelectronic Devices", Pearson                     | 2001                       |
| 5.        | Jaeger R. C., "Introduction to Microelectronic Fabrication", 2nd Ed.,   | 2001                       |
|           | Prentice Hall   |                            |